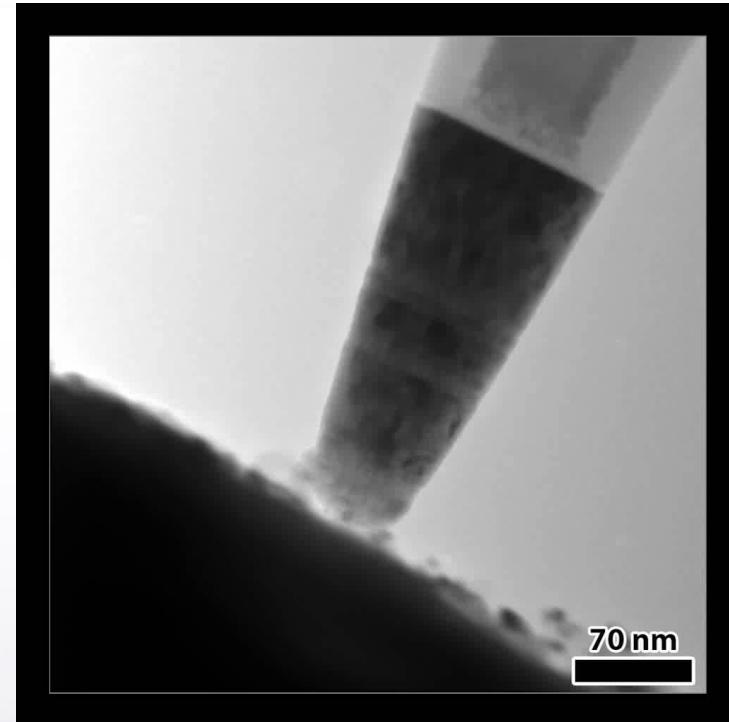


Progress Towards *In situ* TEM Experiments in Combinations of Extreme Environments

SAND2014-20274C

K. Hattar, D.C. Bufford, M. Marshall, D.L. Buller, and B.L. Doyle
Sandia National Laboratories

December 1, 2014



Collaborators:

- Sandia: [C. Chisholm](#), B.G. Clark, [S. H. Pratt](#), Sandia: B. Boyce, T.J. Boyle, [P.J. Cappillino](#), [J.A. Scott](#), B.W. Jacobs, M.A. Hekmaty, D.B. Robinson, E. Carnes, J. Brinker, D. Sasaki, [J.A. Sharon](#), T. Nenoff, W.M. Mook
- External: A. Minor, L.R. Parent, I. Arslan, H. Bei, E.P. George, P. Hosemann, D. Gross, J. Kacher, & I.M. Robertson



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Benefits & Limitations of *in situ* TEM

Benefits

1. Real-time nanoscale resolution observations of microstructural dynamics

Limitations

1. Predominantly limited to microstructural characterization
 - Some work in thermal, optical, and mechanical properties
2. Limited to electron transparent films
 - Can often prefer surface mechanisms to bulk mechanisms
 - Local stresses state in the sample is difficult to predict
3. Electron beam effects
 - Radiolysis and Knock-on Damage
4. Vacuum conditions
 - 10^{-7} Torr limits gas and liquid experiments feasibility
5. Local probing
 - Portion of the world or even a 3mm disk studied is small

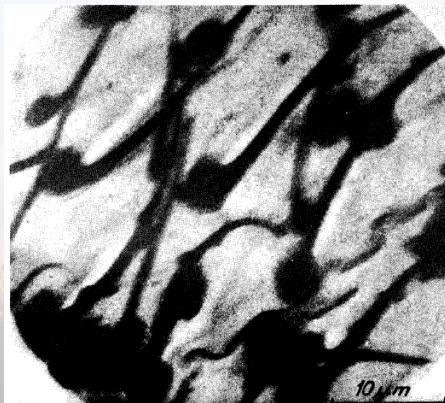


Fig. 6: Wing surface of the house fly.
(First internal photography, $U = 60$ kV, $M_s = 2200$)
(Driess, E., and Müller, H.O.: Z. Wiss. Mikroskopie 52, 53-57 (1935))

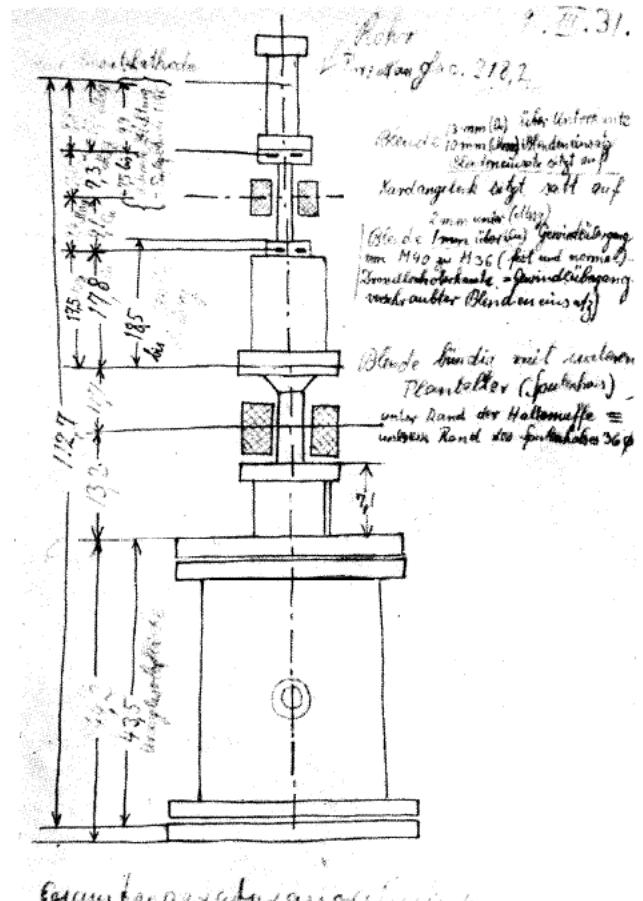
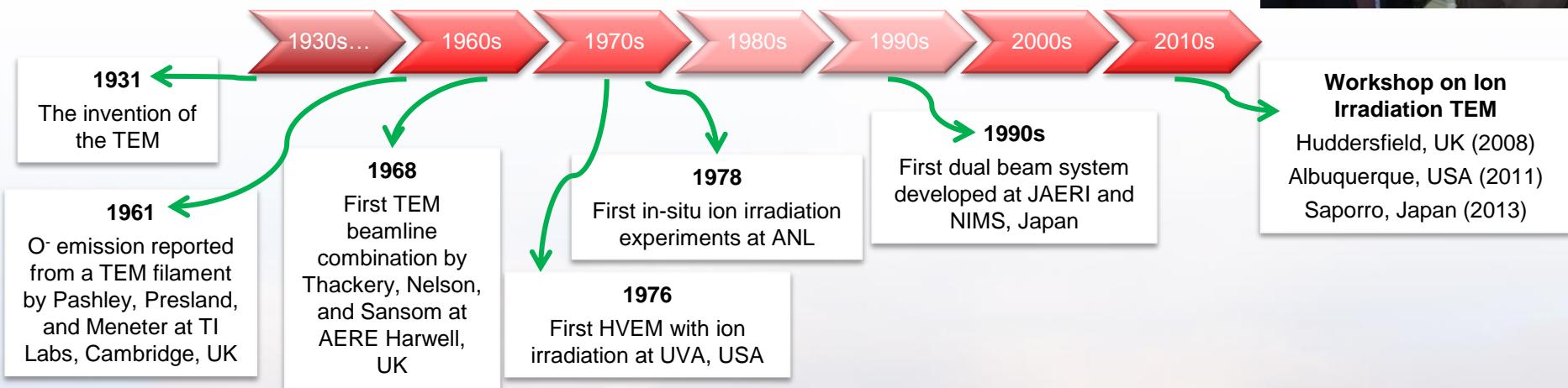
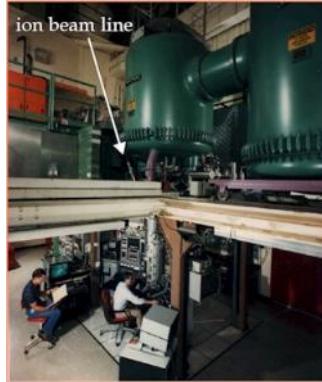


Fig. 2: Sketch by the author (9 March 1931) of the cathode ray tube for testing one-stage and two-stage electron-optical imaging by means of two magnetic electron lenses (electron microscope) [8].



History of *In situ* Ion Irradiation TEM

Courtesy of: J. Hinks



“The direct observation of ion damage in the electron microscope thus represents a powerful means of studying radiation damage”

D.W. Pashley and A.E.B. Presland Phil Mag. 6(68) 1961 p. 1003



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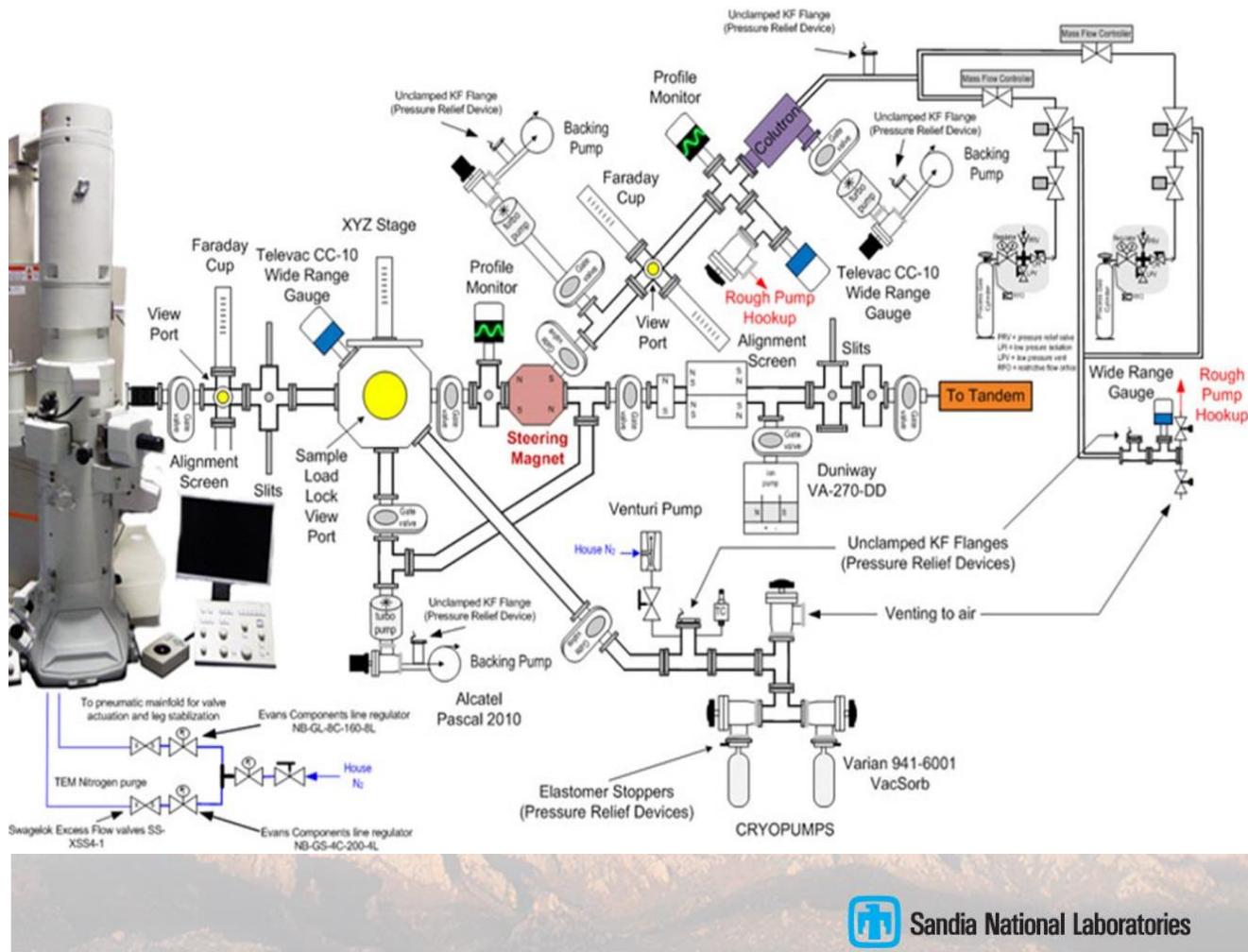
In situ Ion Irradiation TEM (I³TEM) Facility

Collaborators: J.A. Scott

Proposed Capabilities

- 200 kV LaB₆ TEM
- Ion beams considered:
 - Range of Sputtered Ions
 - 10 keV D₂⁺
 - 10 keV He⁺
- All beams hit same location
- Nanosecond time resolution (DTEM)
- Procession scanning (EBSD in TEM)
- In situ PL, CL, and IBIL
- In situ vapor phase stage
- In situ liquid mixing stage
- In situ heating
- Tomography stage (2x)
- In situ cooling stage
- In situ electrical bias stage
- In situ straining stage

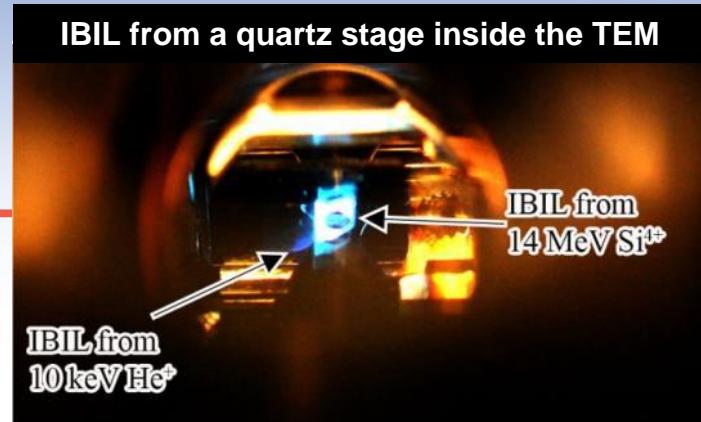
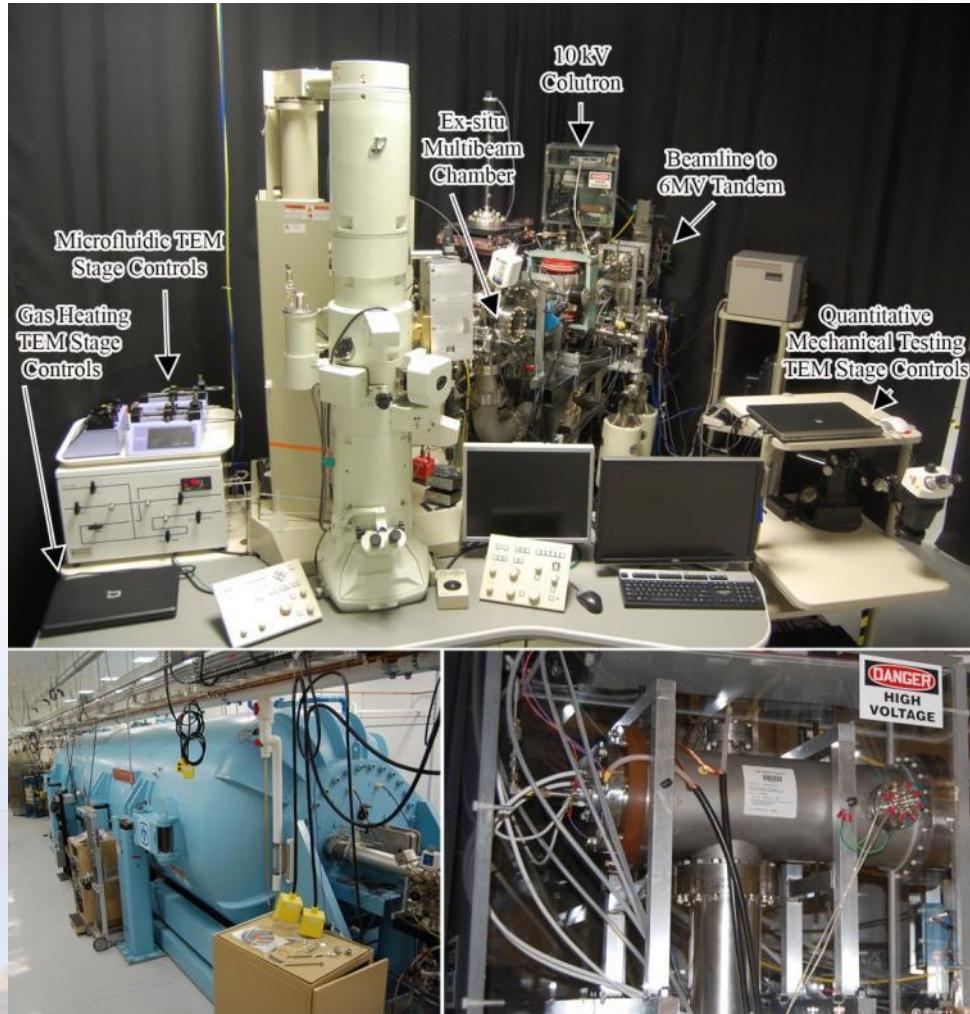
Schematic of the *In situ* TEM Beamlne



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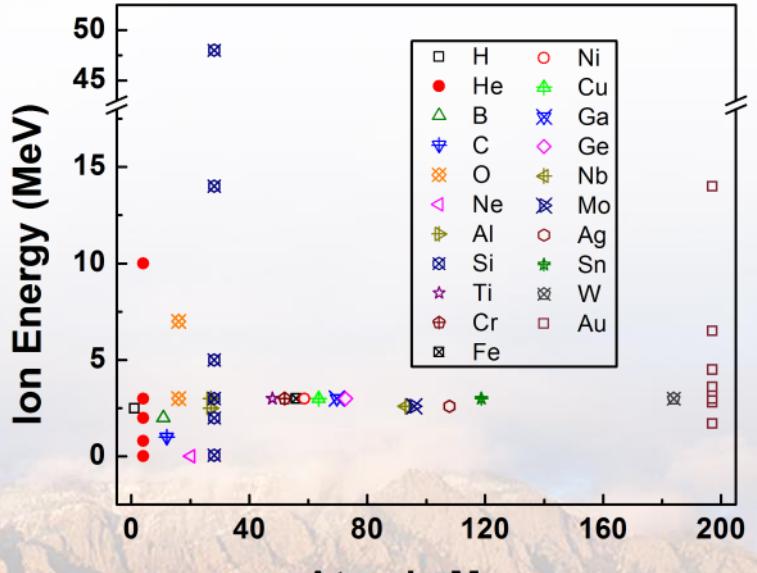
Sandia's Concurrent I³TEM Facility

10 kV Colutron - 200 kV TEM - 6 MV Tandem



Direct real time observation
of ion irradiation,
ion implantation, or both
with nanometer resolution

Ion species & energy introduced into the TEM



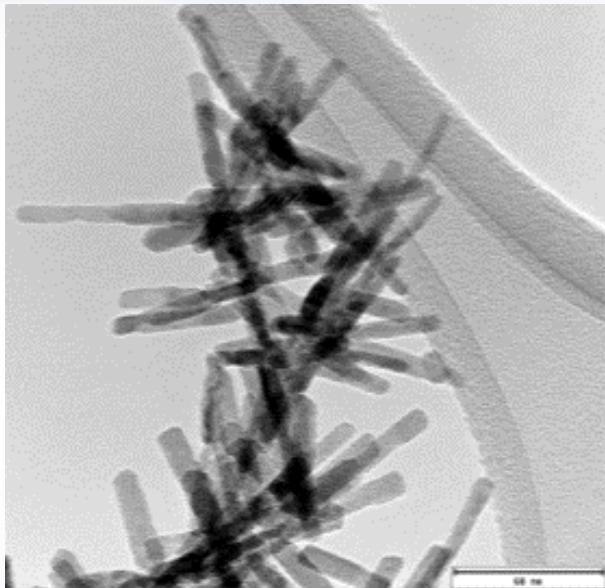
Atomic Mass



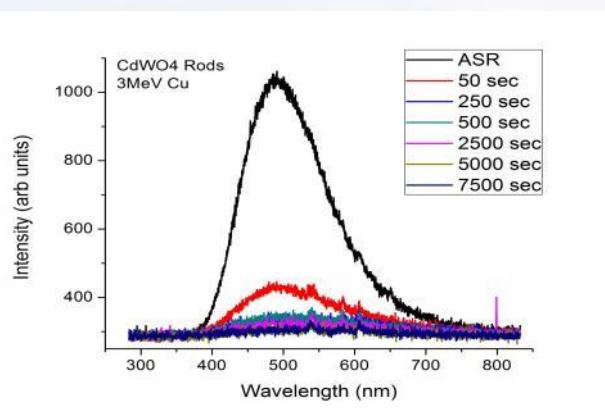
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Radiation Tolerance is Needed in Advanced Scintillators for Non-proliferation Applications

Contributors: S.M. Hoppe, B.A. Hernandez-Sanchez, T. Boyle



High-Z nanoparticles are promising, but are radiation sensitive



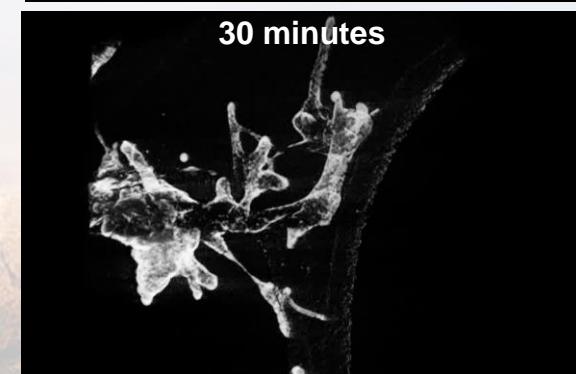
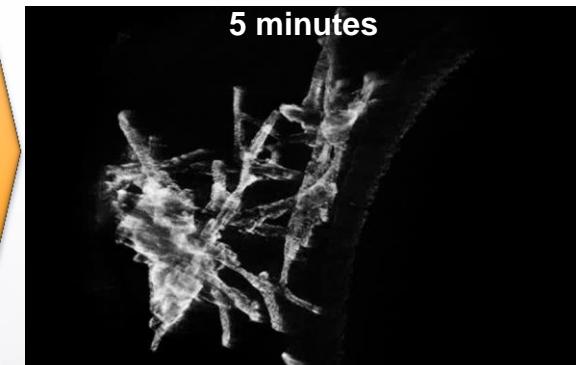
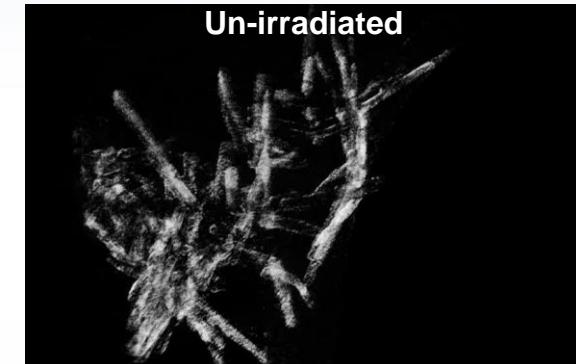
In situ Ion Irradiation TEM (I³TEM)




Hummingbird
tomography stage



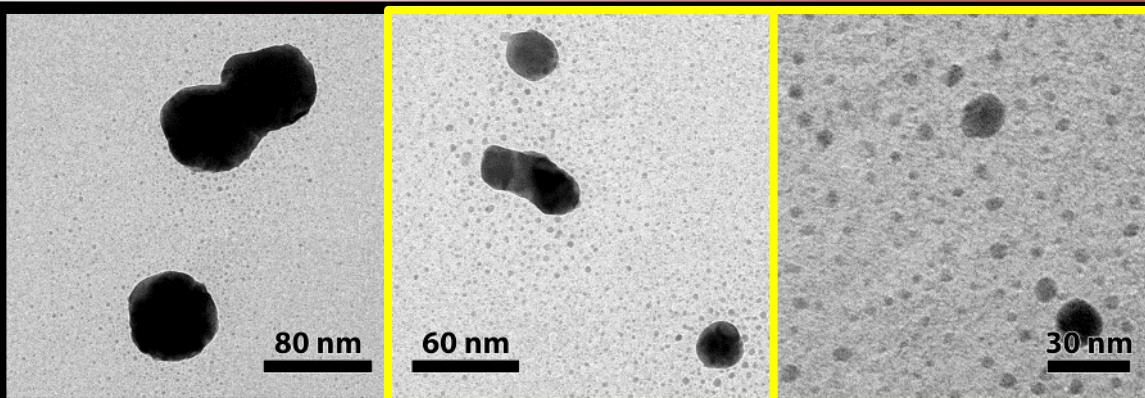
Tomography of Irradiated CdWO₄:
3 MeV Cu³⁺ at ~30 nA



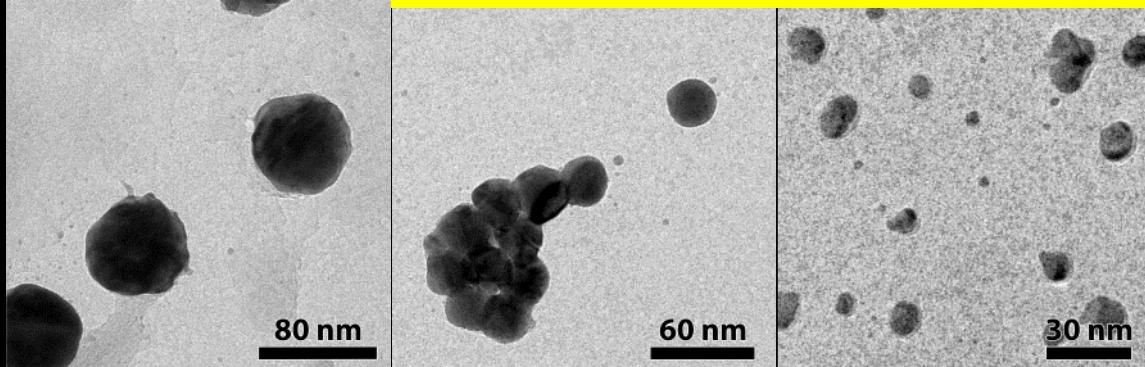
Cumulative Effects of Ion Irradiation as a Function of Ion Energy and Au Particle Size



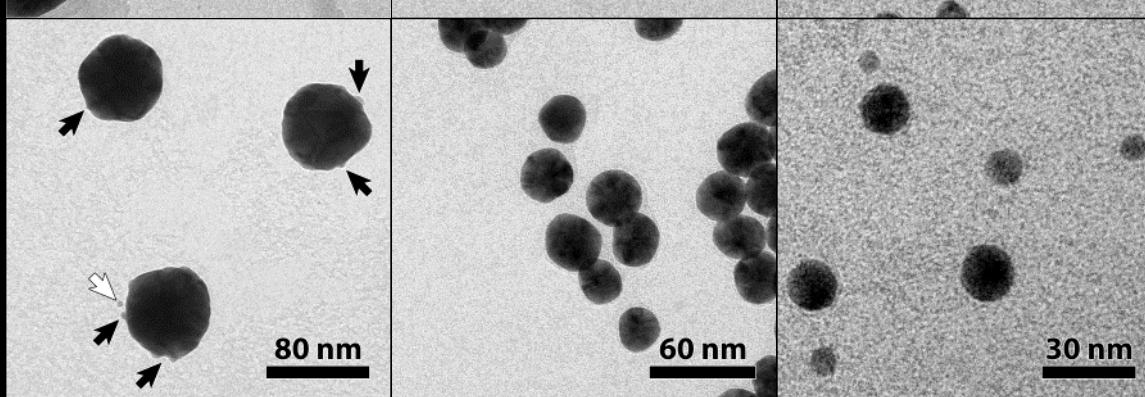
46 keV Au¹⁻
 $3.4 \times 10^{14} /cm^2$



2.8 MeV Au⁴⁺
 $4 \times 10^{13} /cm^2$

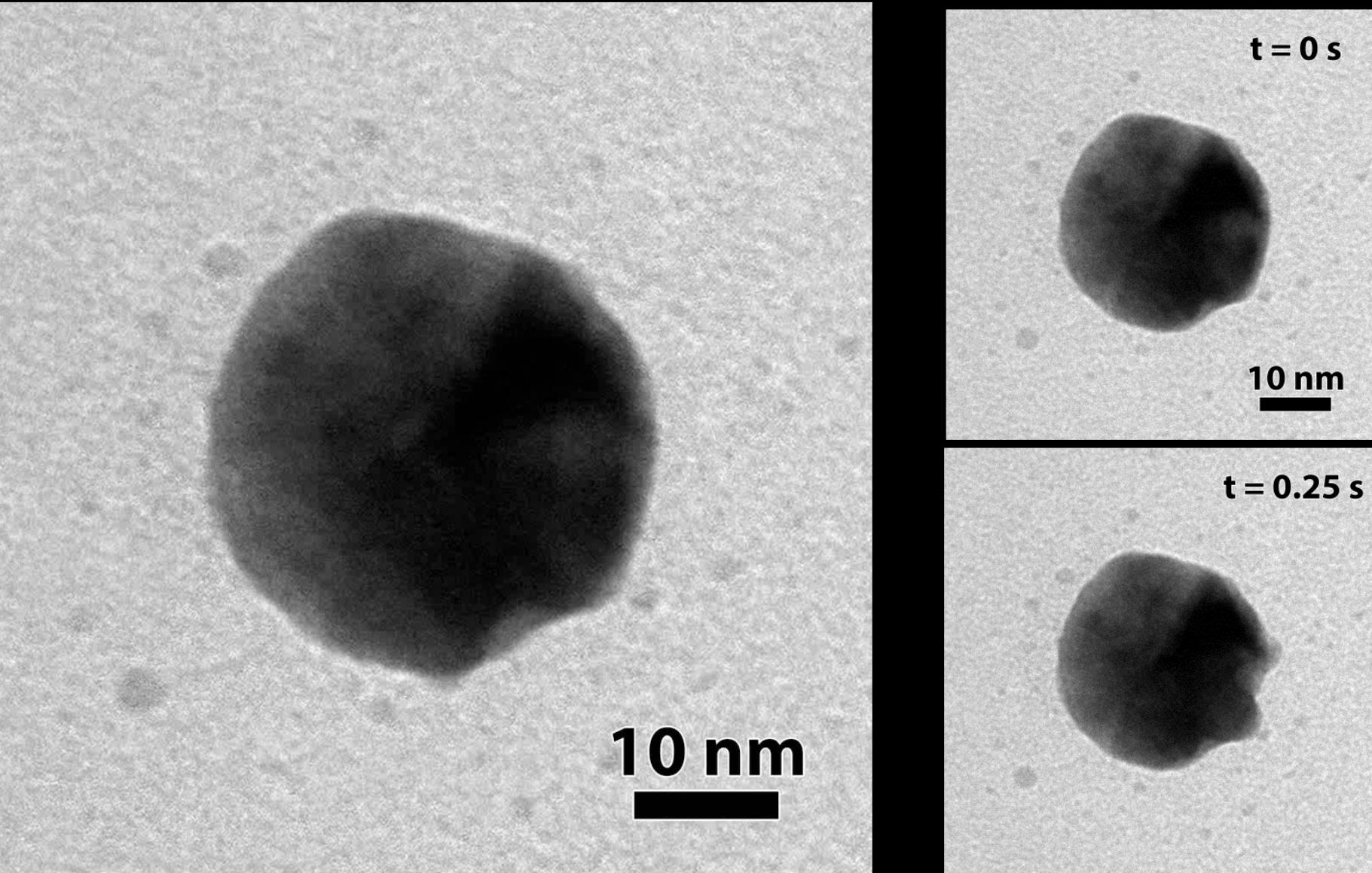


10 MeV Au⁸⁺
 $1.3 \times 10^{12} /cm^2$

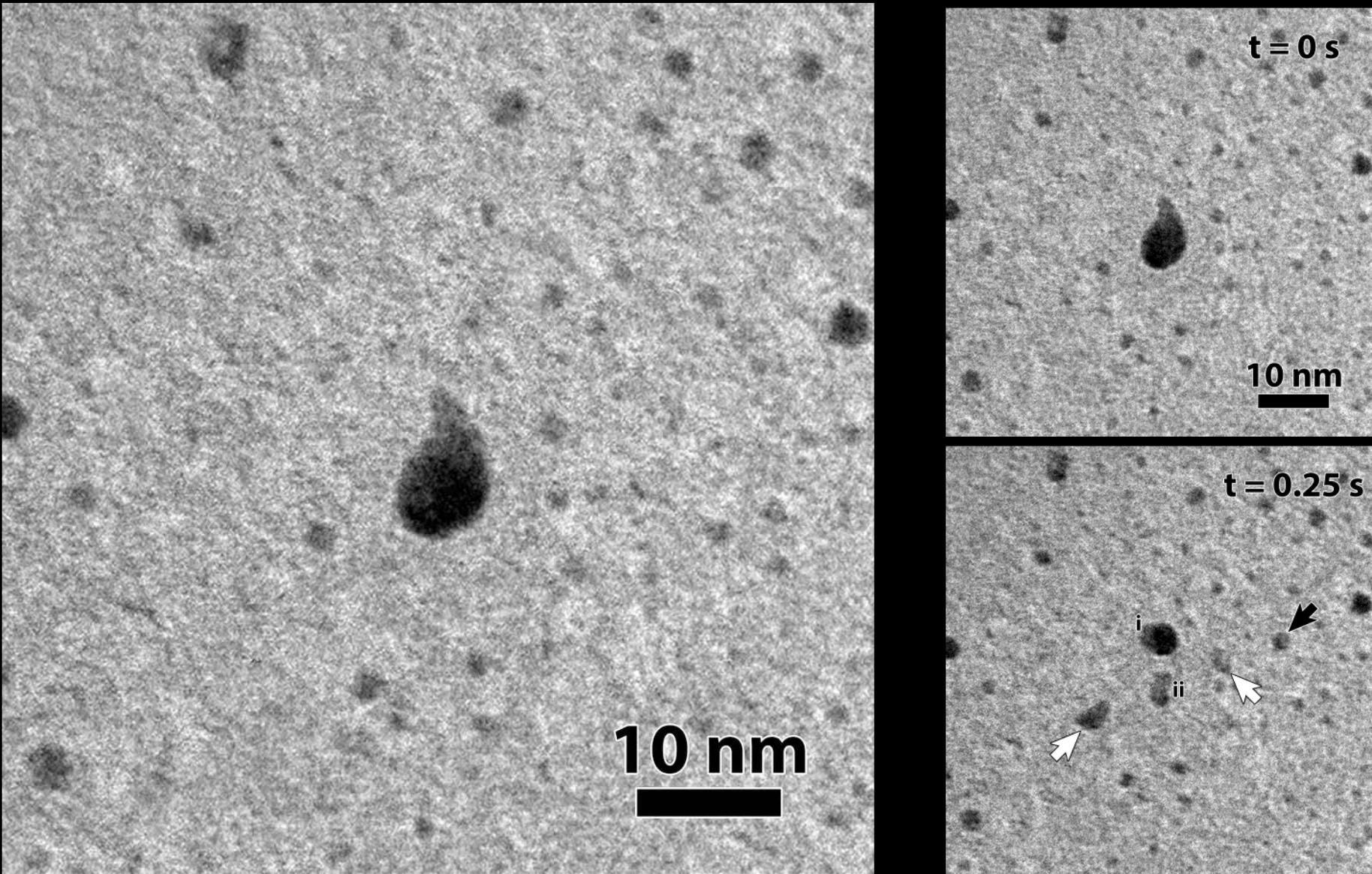


Particle and ion energy dictate the ratio of sputtering, particle motion, particle agglomeration, and other active mechanisms

Single Ion Effects with 46 keV Au¹⁻ ions: 20 nm



Single Ion Effects with 46 keV Au^{1-} ions: 5 nm



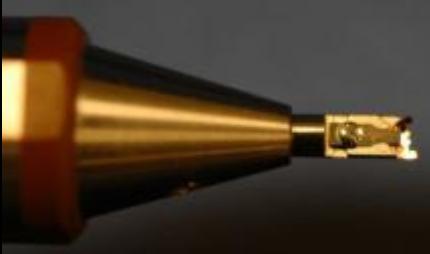
Advanced Microscopy Techniques Applied to Nanoparticles in Radiation Environments

Collaborators: S.M. Hoppe & T.J. Boyle

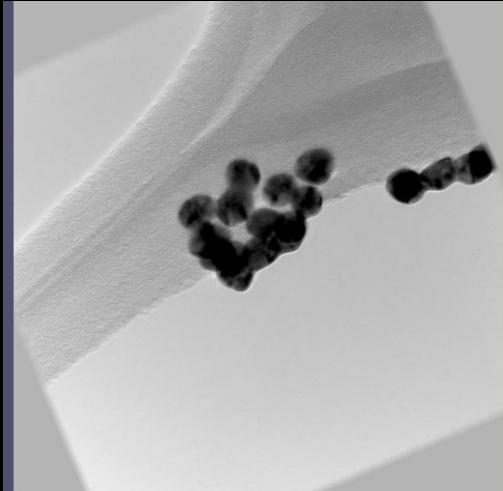
In situ Ion Irradiation TEM (I³TEM)



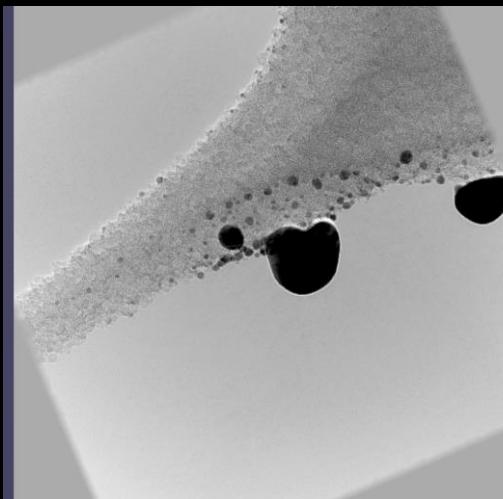
Hummingbird
tomography stage



Aligned Au NP tilt series -
unirradiated



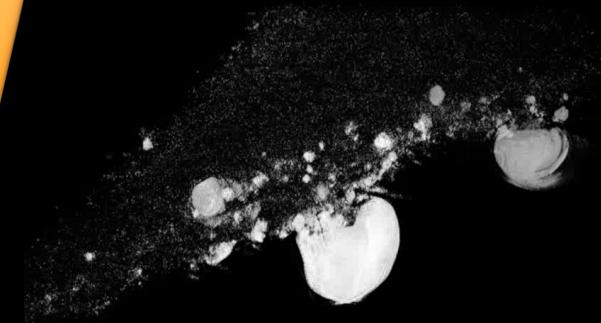
Aligned Au NP tilt series -
irradiated



Unirradiated Au NP model



Irradiated Au NP model



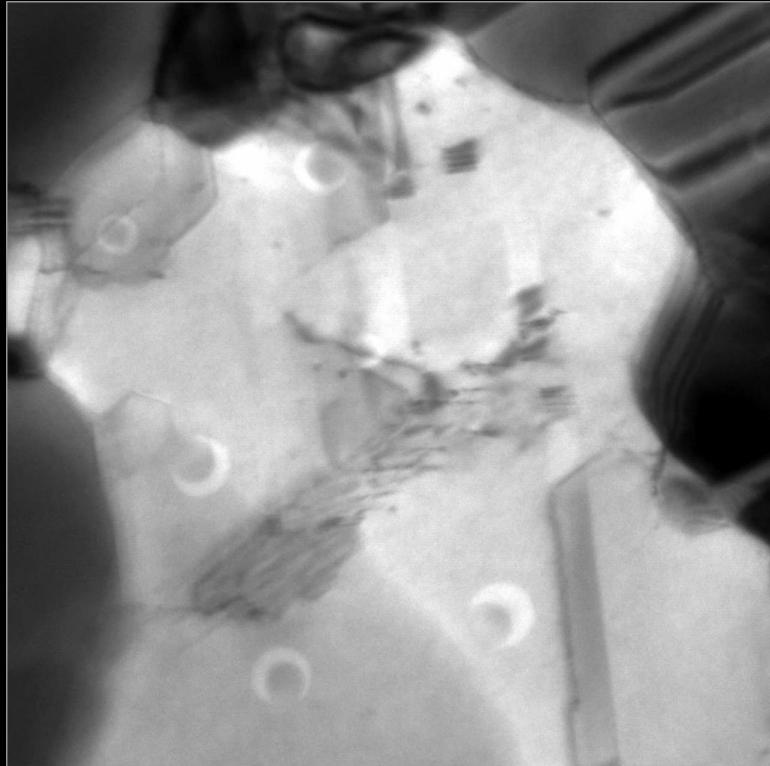
The application of advanced
microscopy techniques to
extreme environments provides
exciting new research directions



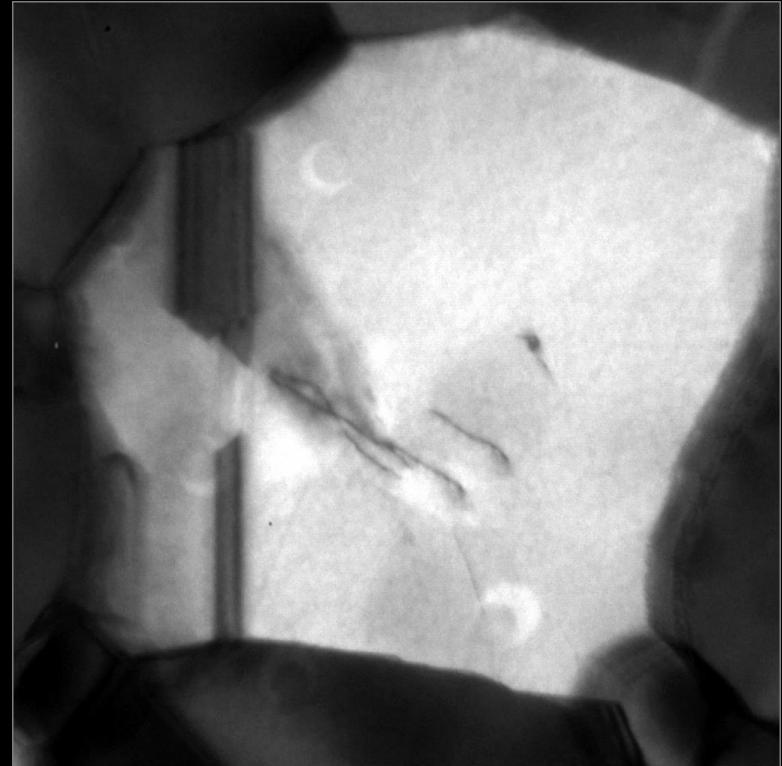
Single Ion Strikes

Collaborators: C. Chisholm & A. Minor

7.9×10^9 ions/cm²/s



6.7×10^7 ions/cm²/s



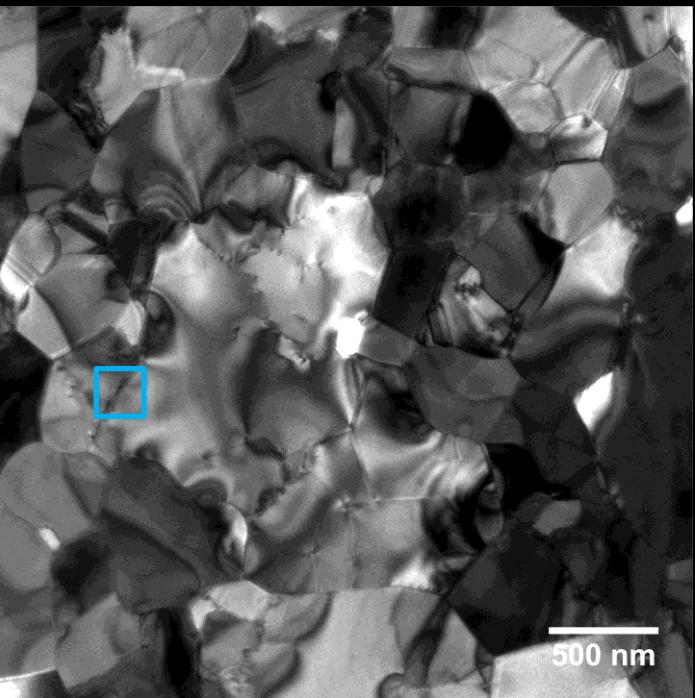
VS

Improved vibrational and ion beam stability permits us to work at 400 kx or higher permitting imaging of single cascade events



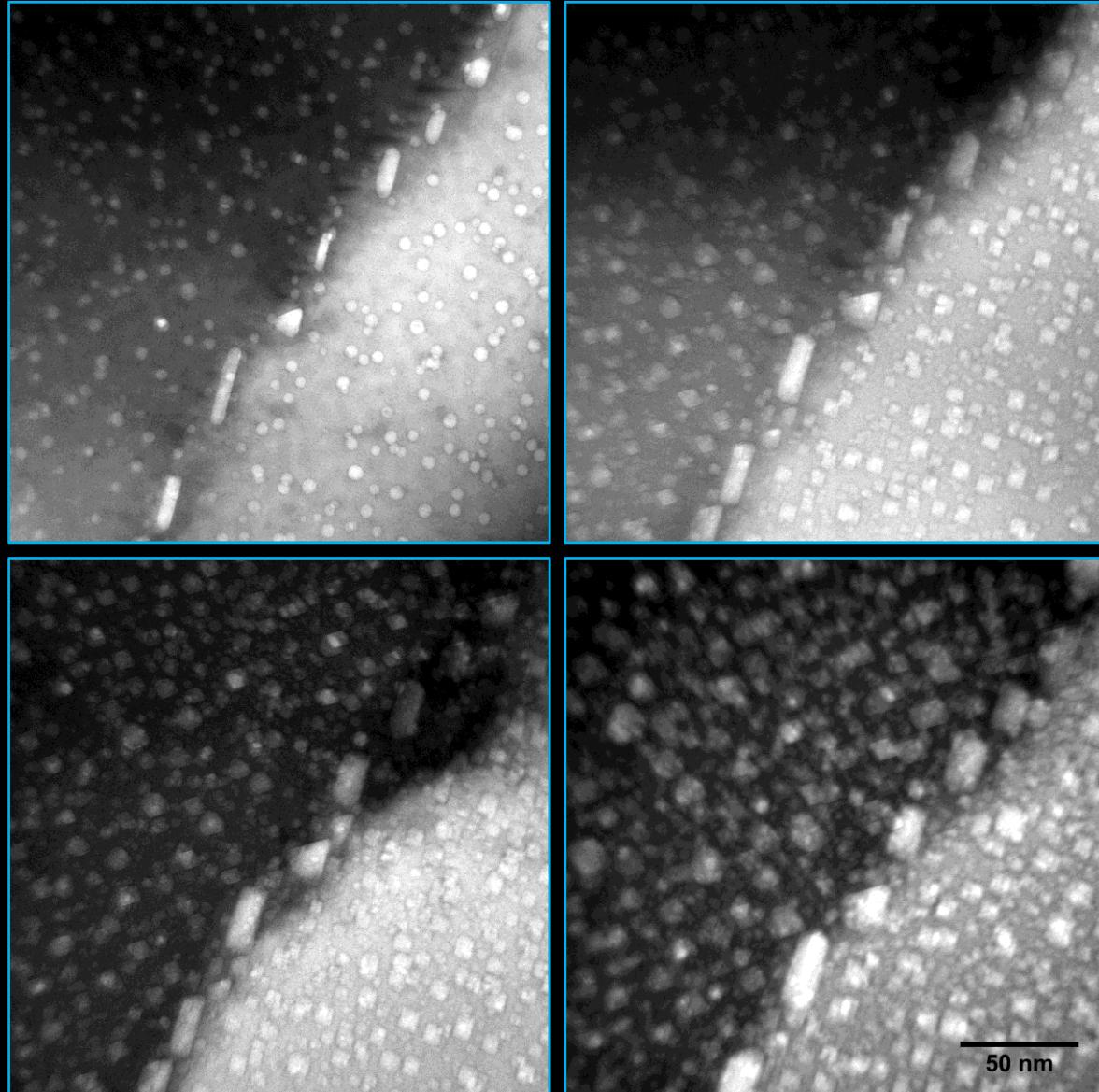
In situ Implantation

Collaborators: C. Chisholm & A. Minor

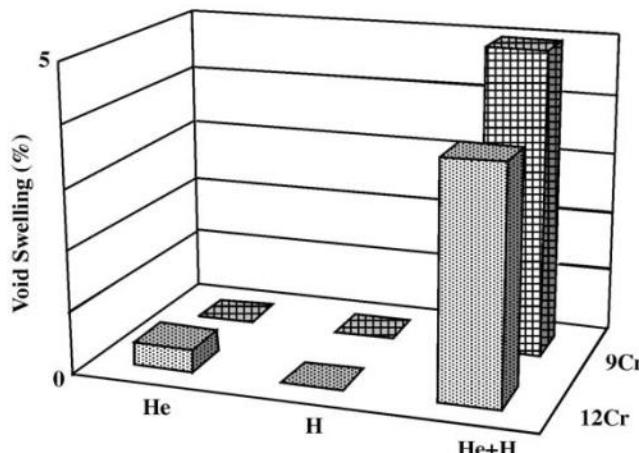
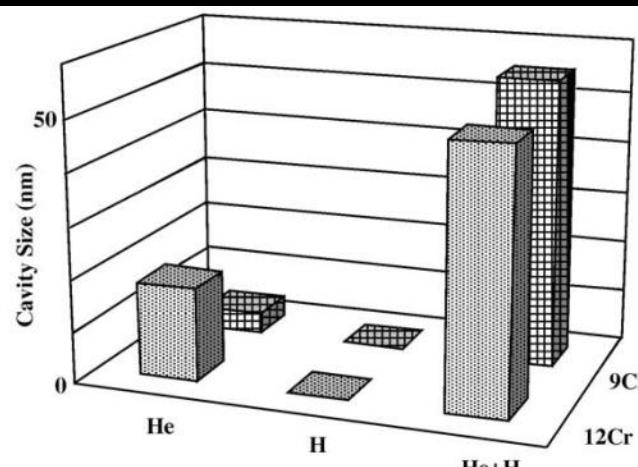
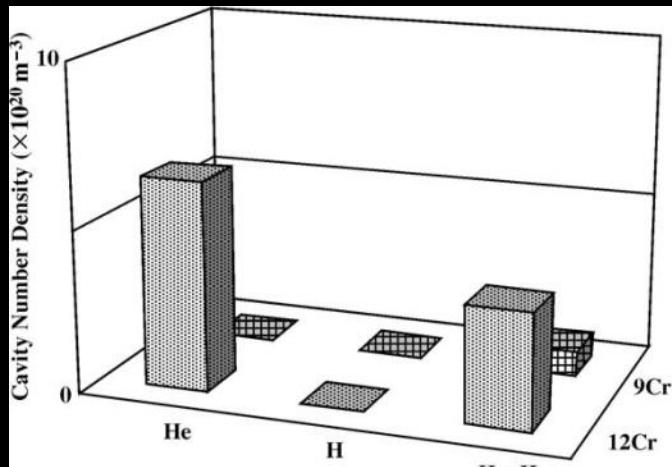


**Gold thin-film implanted
with 10keV He^{2+}**

**Result: porous
microstructure**



H, He, and Displacement Damage Synergy



T. Tanaka et al. "Synergistic effect of helium and hydrogen for defect evolution under multi-ion irradiation of Fe-Cr ferritic alloys"

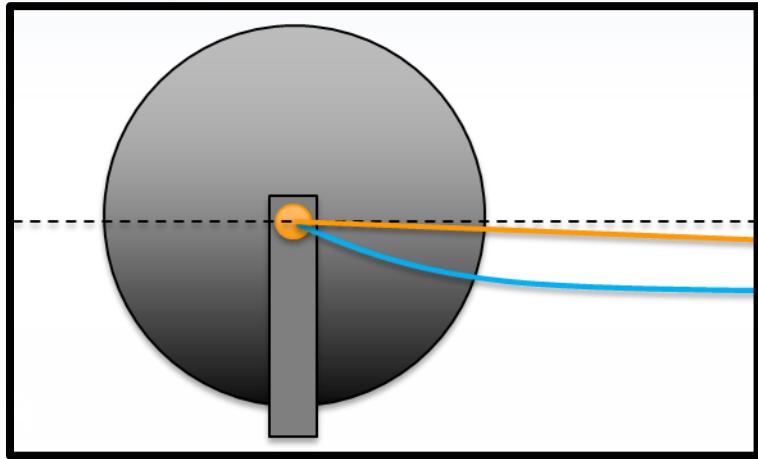
J. of Nuclear Materials 329-333 (2004) 294-298

Coupling Effect

- H and He are produced as decay products
- The relationship between the point defects present, the interstitial hydrogen, and the He bubbles in the system that results in the increased void swelling has only been theorized.
- The mechanisms which governs the increased void swelling under the presence of He and H have never been experimental determined

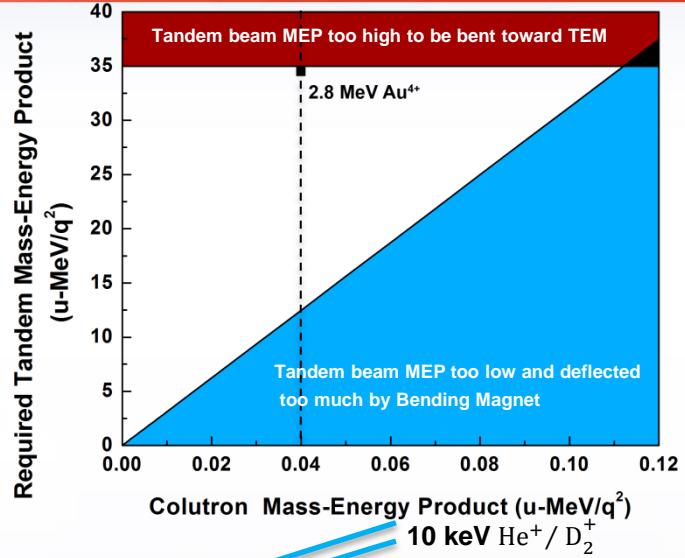
Difficulty of performing triple-beam irradiation has resulted in a limited number of facilities world wide

Modeling Beam Mixing and Deflection



TEM
Obj. Lens

Bending
Magnet



Colutron Mass-Energy Product ($u\text{-MeV}/q^2$)
10 keV He^+/D_2^+

Steering Magnet

20°

2.8 MeV Au^{4+}

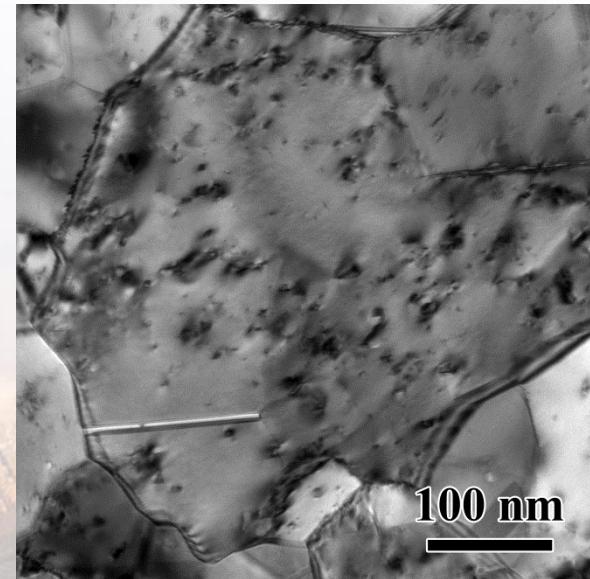
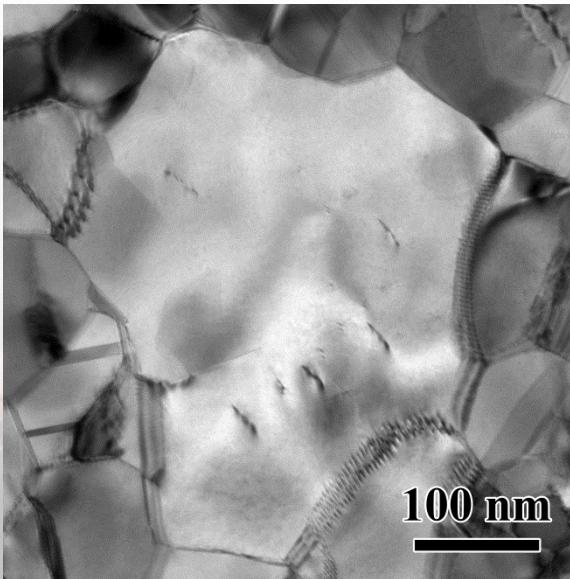
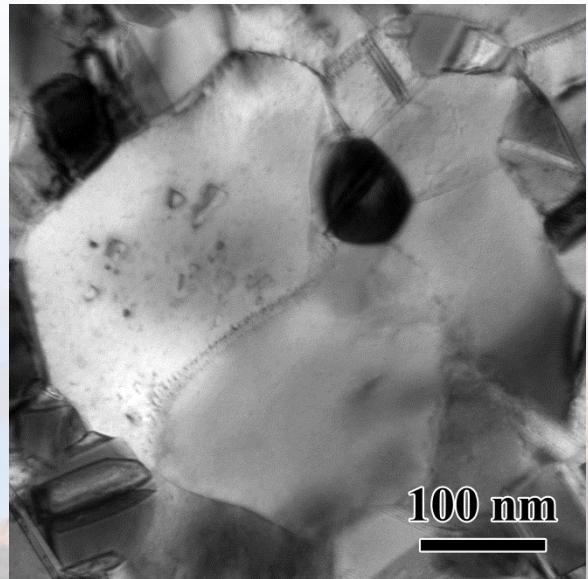
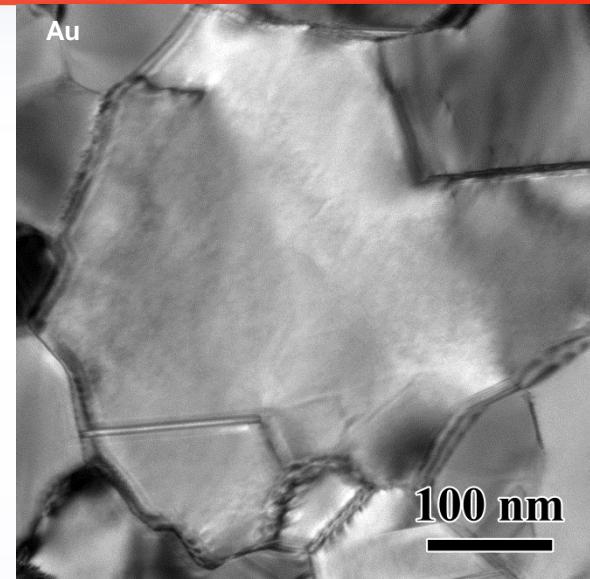
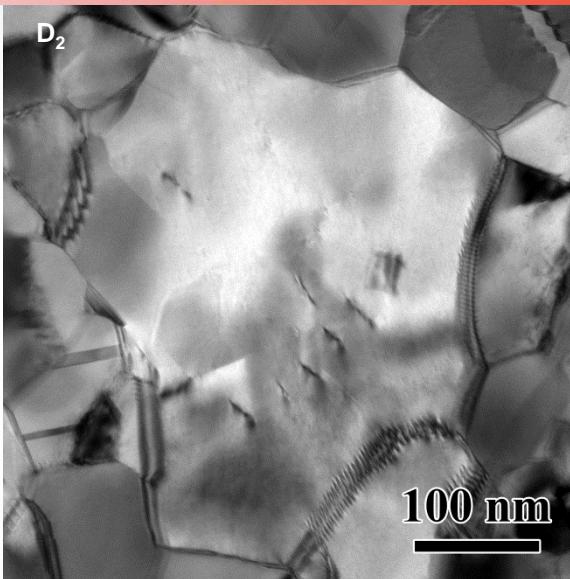
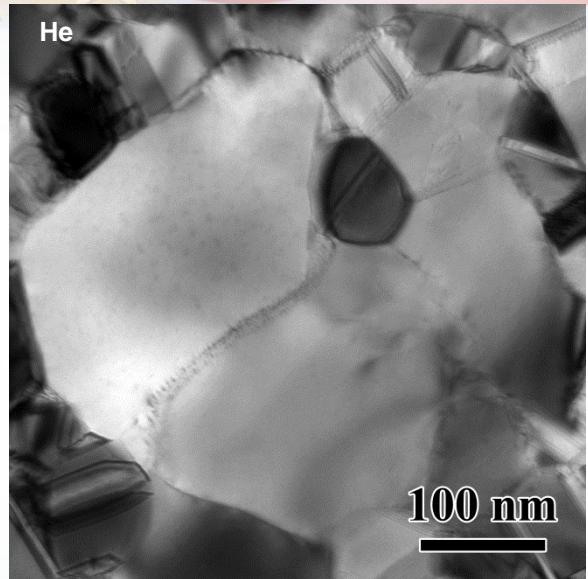
- Must compensate for deflection of Tandem beam by bending magnet
- Colutron beams deflected by the TEM objective lens
- Insignificant deflection of Tandem beams
- With 10 keV He/D_2 we can use Tandem beams $\gtrapprox 13 \text{ MeV}/q^2$
- Au, He, and D_2 ions all reach the sample concurrently



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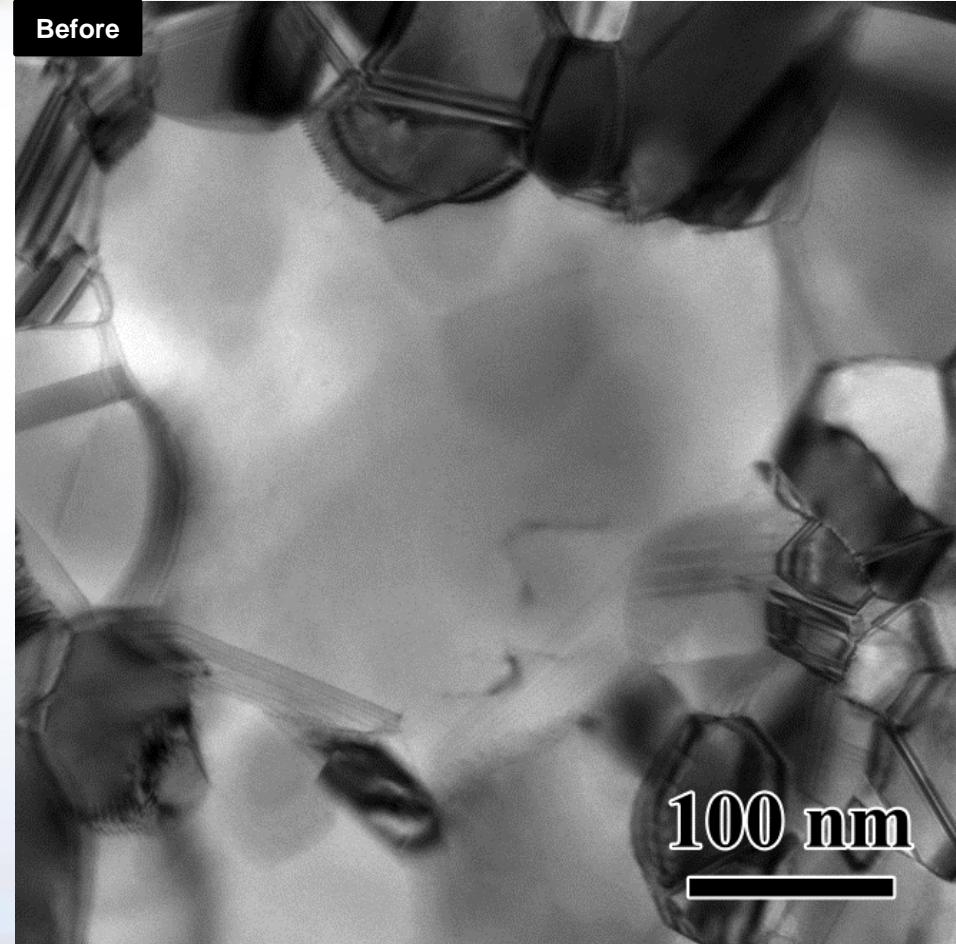


Aligned Individual Beams

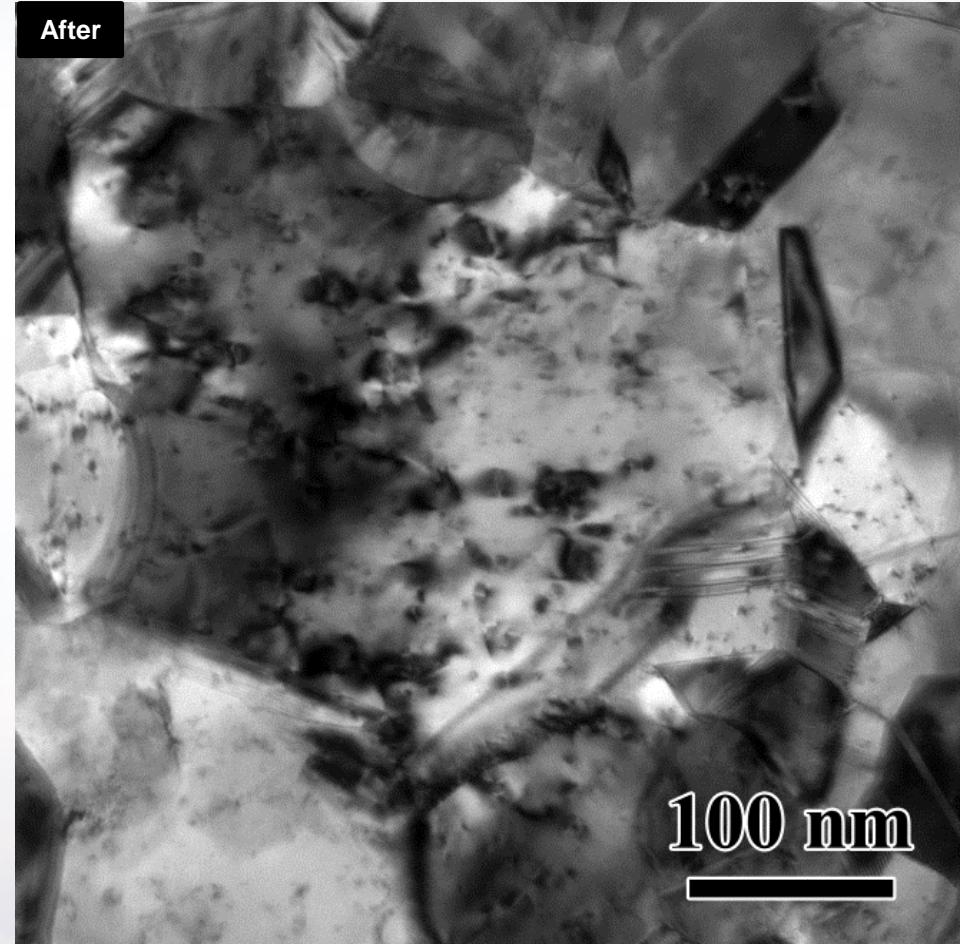


Concurrent 10 keV He, 10 keV D₂, and 3 MeV Au

Before



After

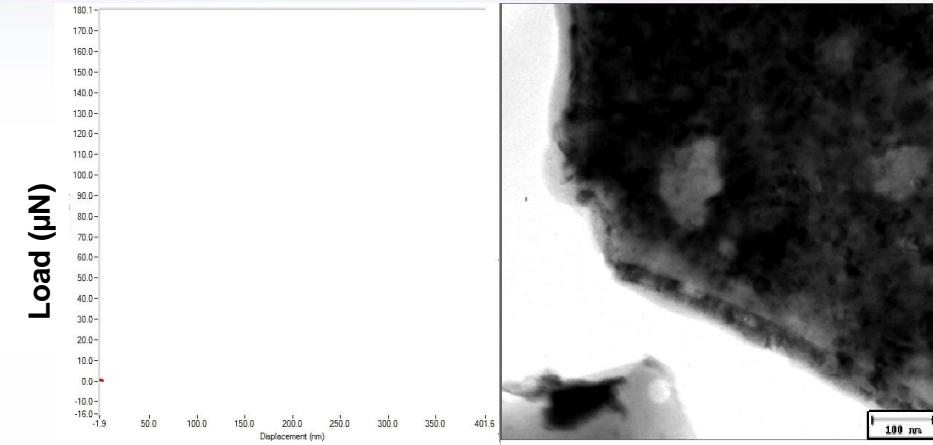
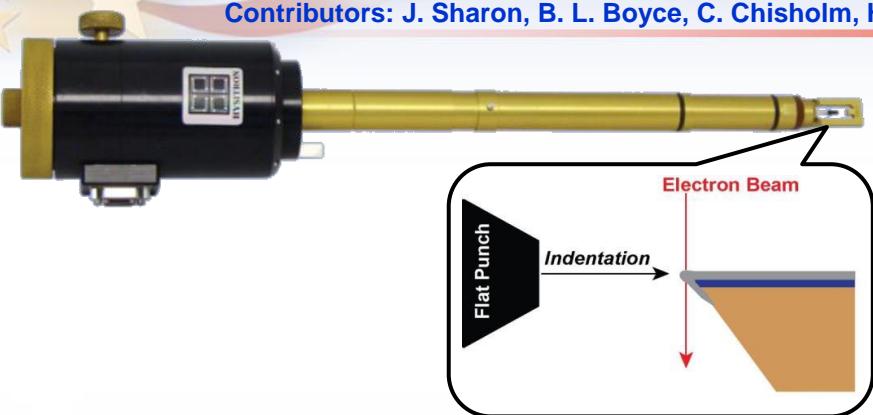


In-situ triple beam He, D₂, and Au beam irradiation has been demonstrated on Sandia's I³TEM!

Extensive work is still needed to understand the defect structure evolution that has been observed.

Next Steps: *In situ* TEM Quantitative Mechanical Testing

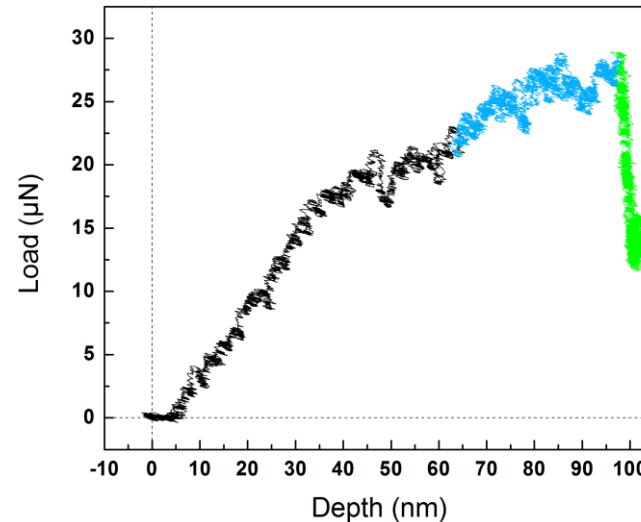
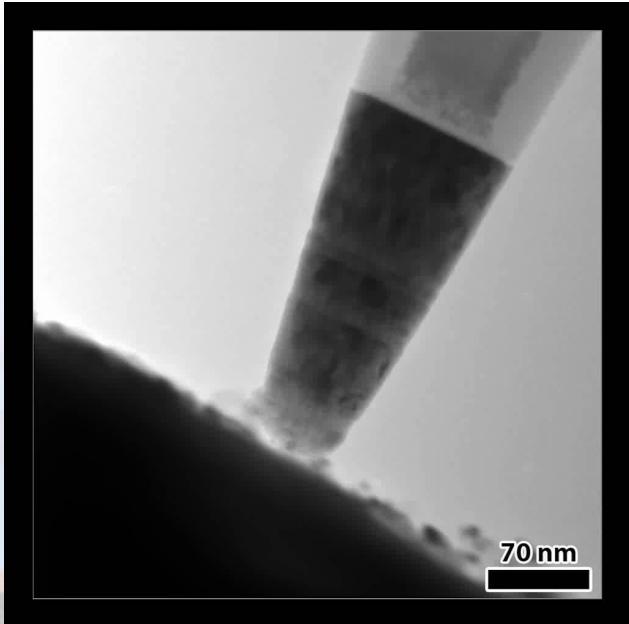
Contributors: J. Sharon, B. L. Boyce, C. Chisholm, H. Bei, E.P. George, P. Hosemann, A.M. Minor, & Hysitron Inc.



Range of Mechanical Testing Techniques

- Indentation
- Compression
- Tension
- Wear
- Fatigue
- Creep

Fundamentals of Mechanical Properties

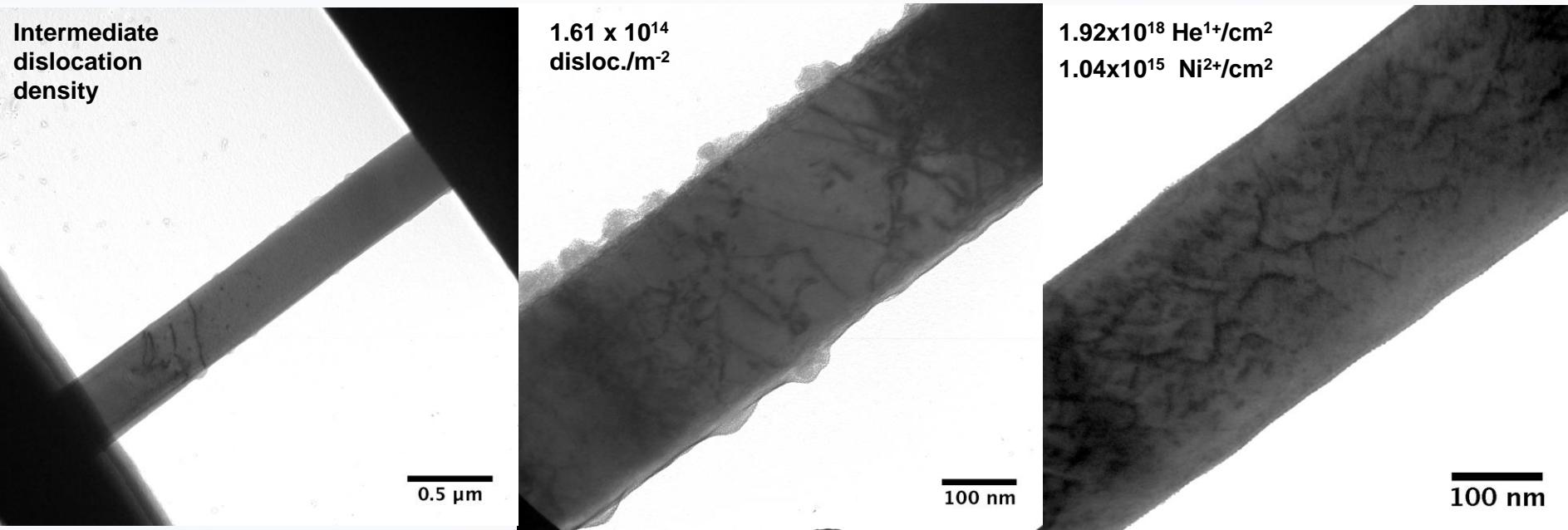


- 0.5 nm/s loading rate
- Trapezoid load function
- 60s load/60s hold/60s unload

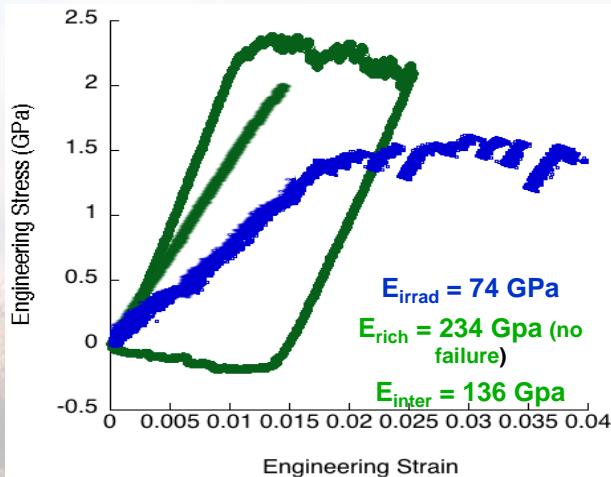
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Next Steps: *In situ* TEM Quantitative Mechanical Testing

Contributors: C. Chisholm, H. Bei, E.P. George, P. Hosemann, & A.M. Minor



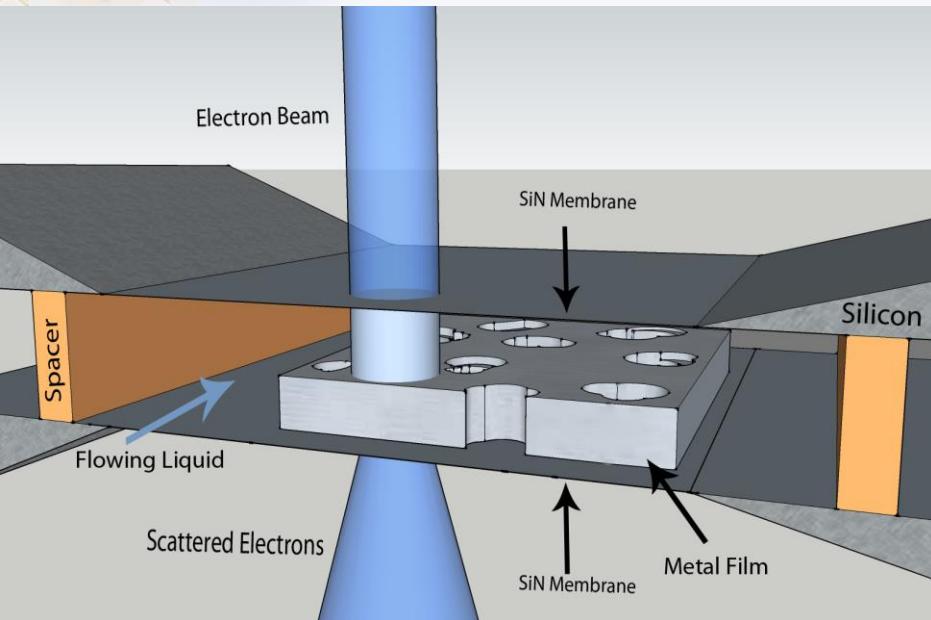
Work has started by looking sequentially at the quantitative effects of ion irradiation on mechanical properties utilizing in-situ ion irradiation TEM and in-situ TEM straining.



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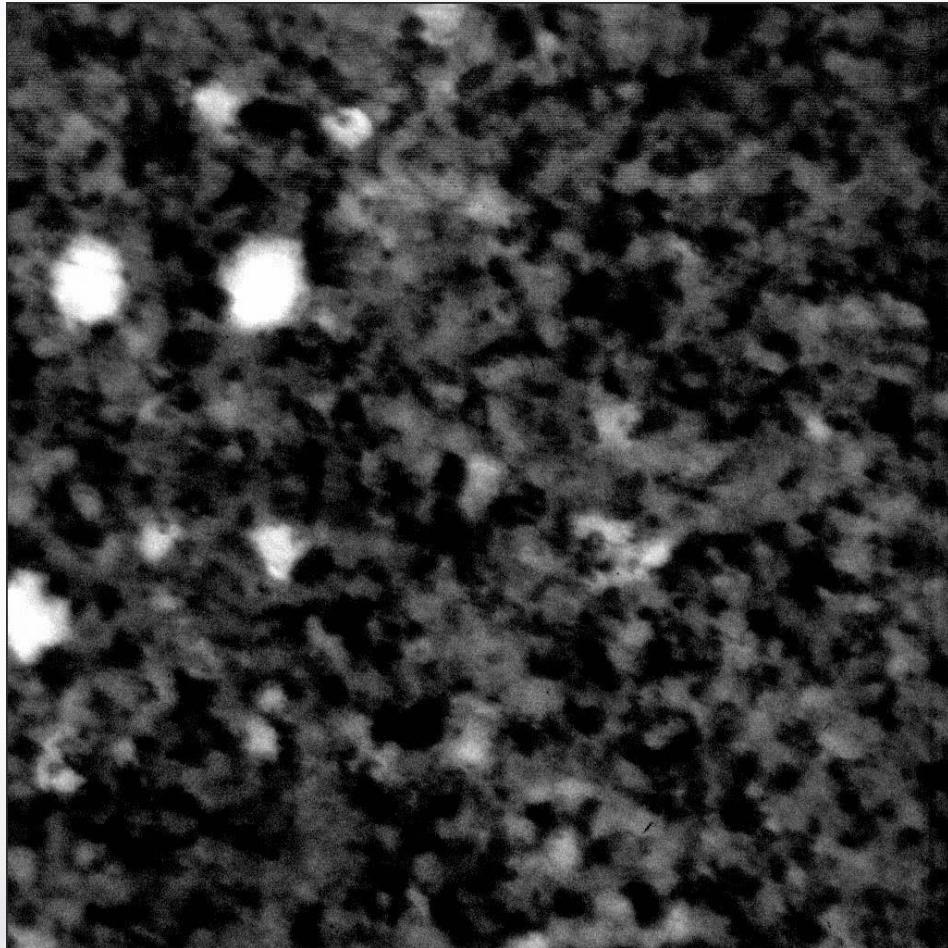
Next steps: *In situ* TEM Corrosion

Contributors: D. Gross, J. Kacher, & I.M. Robertson



Microfluidic Stage

- Mixing of two or more channels
- Continuous observation of the reaction channel
- Chamber dimensions are controllable
- Films can be directly deposited on the electron transparent SiN membrane



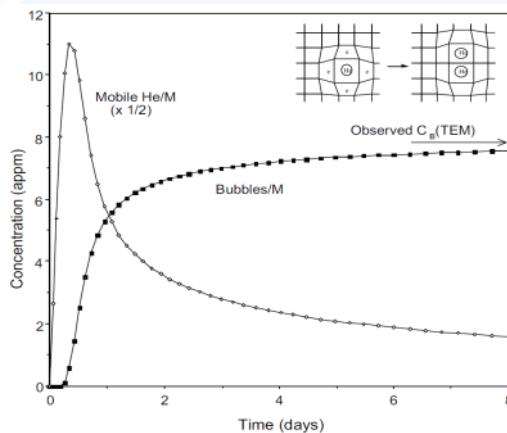
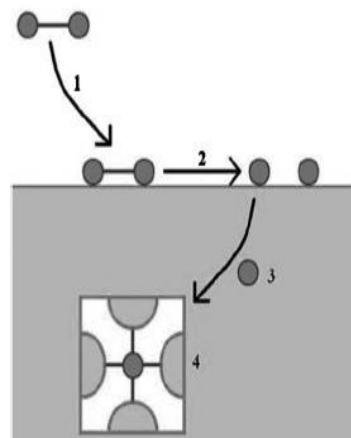
Pitting mechanisms during dilute flow of acetic acid over 99.95% nc-PLD Fe involves many grains.



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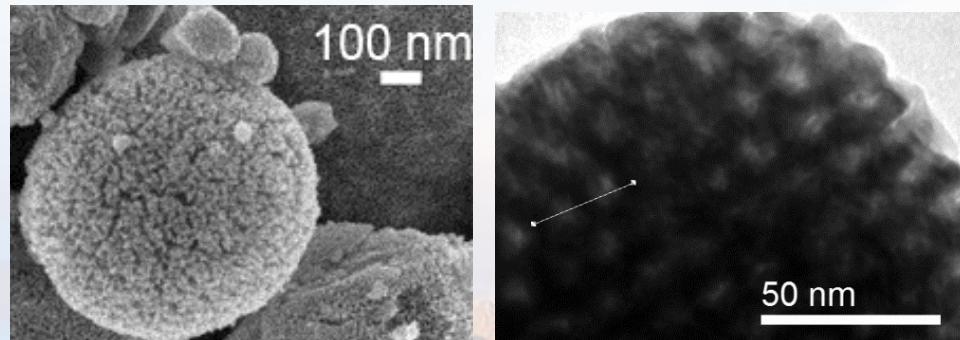
Can *In situ* TEM Address Hydrogen Storage Concerns in Extreme Environments?

Contributors: B.G. Clark, P.J. Cappillino, B.W. Jacobs, M.A. Hekmaty, D.B. Robinson, L.R. Parent, I. Arslan, & Protochips, Inc.



R. Delmelle, J., Phys. Chem. Chem. Phys. (2011) p.11412
Cowgill, D., Fusion Sci. & Tech., 28 (2005) p. 539
Trinkaus, H. et al., JNM (2003) p. 229
Thiebaut, S. et al. JNM (2000) p. 217

Harmful effects may be mitigated in nanoporous Pd

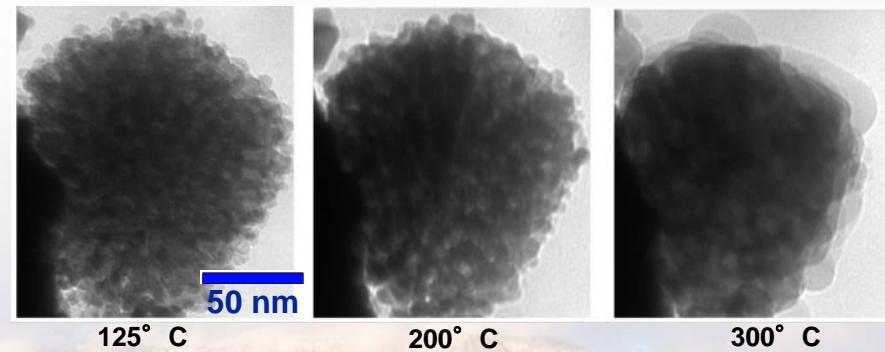


Vapor-Phase Heating TEM Stage

- Compatible with a range of gases
- *In situ* resistive heating
- Continuous observation of the reaction channel
- Chamber dimensions are controllable
- Compatible with MS and other analytical tools



- 1 atm H₂ after several pulses to specified temp.

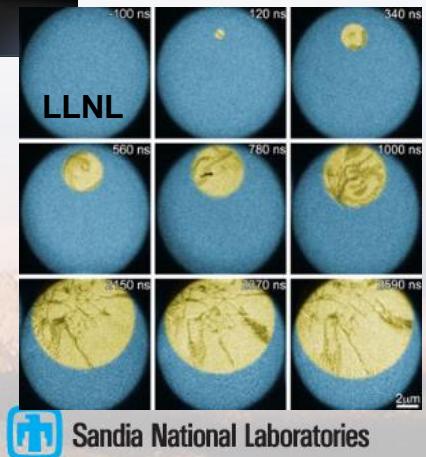
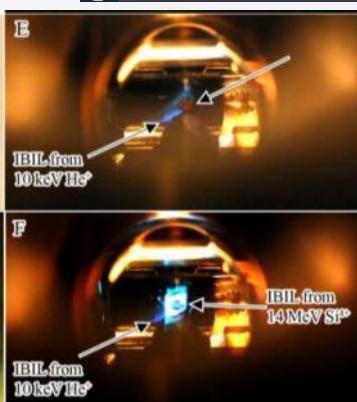
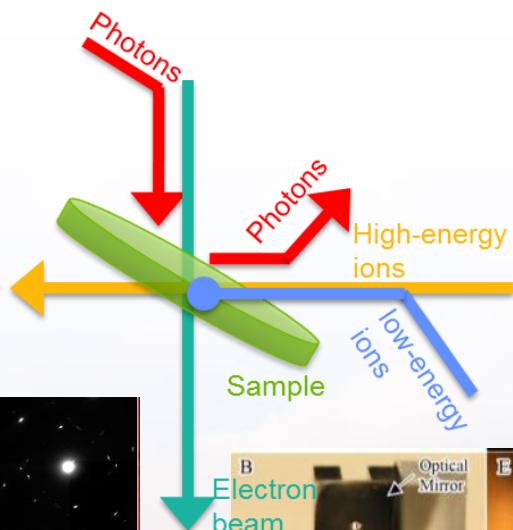
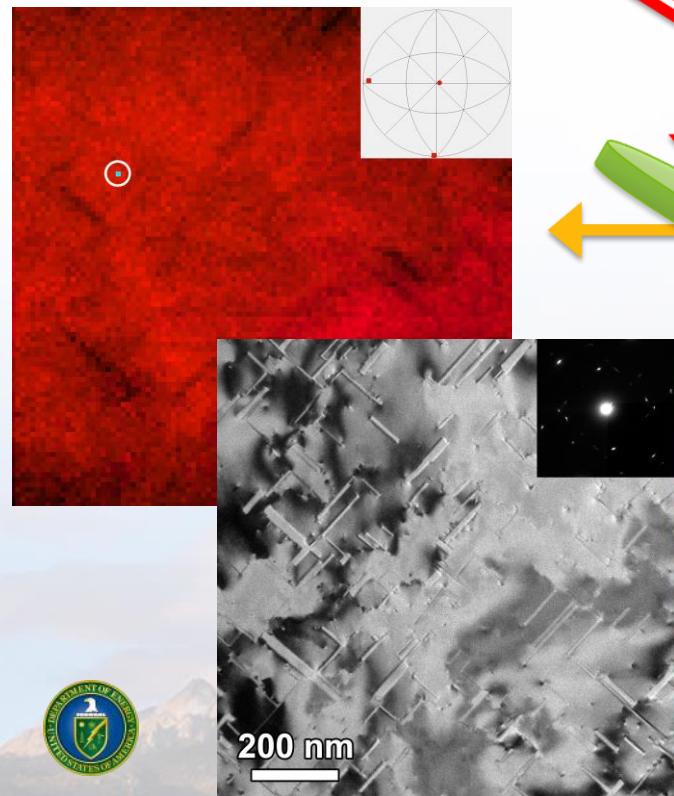
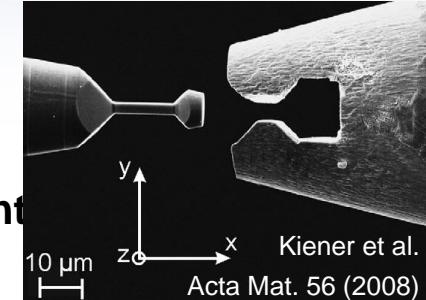


New *In situ* atmospheric heating experiments provide great insight into nanoporous Pd stability



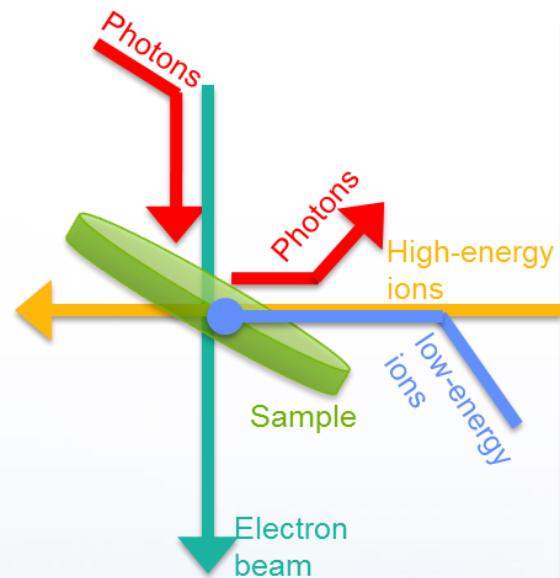
Future Directions Under Pursuit: Increased Data and Combinations of Environments

1. In-situ TEM CL, IBIL (currently capable)
2. *In situ* ion irradiation TEM in liquid or gas (currently capable)
3. PED: Local texture characterization (recently installed)
4. Quantitative in-situ tensile/creep experiments (Sample in development)
5. DTEM: Nanosecond resolution (laser optics needed)



Summary

The Ion Beam Lab at Sandia National Laboratories applies a variety of nanoscale tools to a wealth of problems

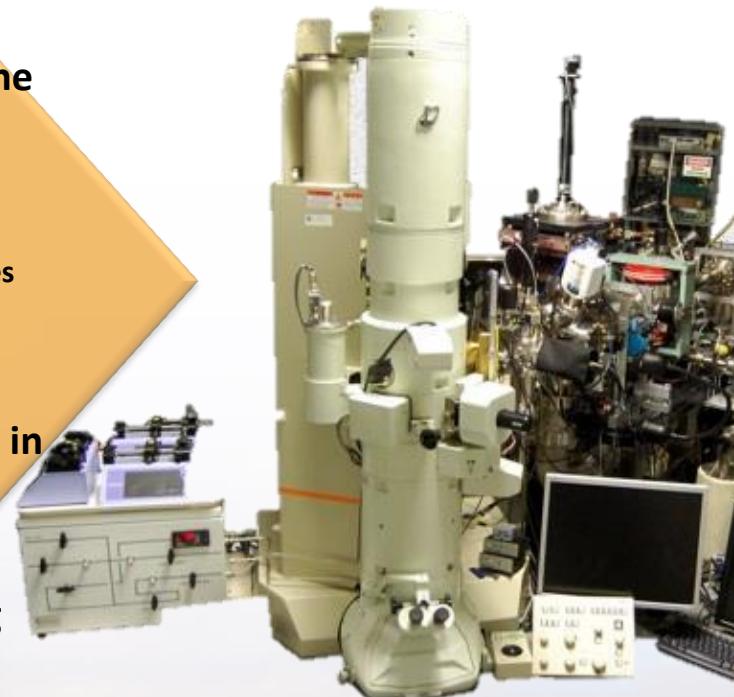


Sandia's I³TEM is one of a few in the world

- *In situ* irradiation from H to Au
- *In situ* gas implantation
- Combinations of in-situ techniques

I³TEM can provide fundamental understanding to key mechanisms in a variety of extreme conditions

The I³TEM capability are still being expanded...



Collaborators:

- Sandia: C. Chisholm, B.G. Clark, S. H. Pratt, Sandia: B. Boyce, T.J. Boyle, P.J. Cappillino, J.A. Scott, B.W. Jacobs, M.A. Hekmaty, D.B. Robinson, E. Carnes, J. Brinker, D. Sasaki, J.A. Sharon, T. Nenoff, W.M. Mook
- External: A. Minor, L.R. Parent, I. Arslan, H. Bei, E.P. George, P. Hosemann, D. Gross, J. Kacher, & I.M. Robertson